

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner		Art Unit		Page 1 of 1
Jeffrey T. Barton		1795		

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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NON-PATENT DOCUMENTS

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U	Ma, W et al, "The Utilization of Microcrystalline Si and SiC for the Efficiency Improvement in a-Si Solar Cells", Conf. Rec. of the 24th IEEE Photovoltaic Specialists Conference, vol 1, p 417-420. (1994)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
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